Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/517,839	PARK, YOUNG II	
Examiner	Art Unit	
Tran N. Nguyen	2834	

Tran N. Nguyen

SEARCHED				
Class	Subclass	Date	Examiner	
310	81 43 268	11/11/	Jan	
	268		/	
<u> </u>				
	,			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

(maccocing or with	I STRATEGY	')
	DATE	EXMR
· · · · · · · · · · · · · · · · · · ·		
	<u> </u>	